## Description

The F1975 Digital Step Attenuator (DSA) is a product in IDT's Glitch-Free™ DSA Family, which is optimized for the demanding requirements of CATV and satellite systems. It operates in the frequency range of 5 MHz to 3000 MHz . This device is offered in a compact $4 \mathrm{~mm} \times 4 \mathrm{~mm}, 20$-pin Thin QFN package with a $75 \Omega$ impedance for ease of integration.

## Advantages

Digital step attenuators are used in receivers and transmitters to provide gain control. The F1975 is a 6 -bit step attenuator optimized for these demanding applications. The silicon design has very low insertion loss and low distortion (+64dBm IIP3). The device has pinpoint attenuation accuracy. Most importantly, the F1975 includes IDT's Glitch-Free ${ }^{\text {TM }}$ technology, which results in low overshoot and ringing during most significant bit (MSB) transitions.

- Glitch-Free ${ }^{\text {TM }}$ technology protects the power amplifier or analog-to-digital converter (ADC) from damage during transitions between attenuation states
- Extremely accurate attenuation levels
- Ultra-low distortion
- Low insertion loss for best signal-to-noise ratio (SNR)


## Typical Applications

- CATV infrastructure
- CATV set-top boxes
- CATV satellite modems
- Data network equipment
- Fiber networks


## Features

- Frequency: 5 MHz to 3000 MHz
- Serial and 6-bit parallel interface
- 31.5 dB control range
- 0.5 dB step
- Glitch-Free ${ }^{T M}$ technology, low transient overshoot
- 3.0 V to 5.25 V supply
- 1.8 V or 3.3 V control logic
- Attenuator step error: 0.1 dB at 1 GHz
- Low insertion loss: 1.2 dB at 1 GHz
- Ultra-linear IIP3: +64dBm
- IIP2: +125dBm typical
- Stable integral non-linearity over temperature
- Low current consumption: $550 \mu \mathrm{~A}$ typical
- Bi-directional
- Operating temperature: $-40^{\circ} \mathrm{C}$ to $+105^{\circ} \mathrm{C}$
- $4 \mathrm{~mm} \times 4 \mathrm{~mm}, 20$-pin QFN package


## Block Diagram

Figure 1. Block Diagram


## Pin Assignments

Figure 2. Pin Assignments for $4 \mathrm{~mm} \times 4 \mathrm{~mm} \times 0.75 \mathrm{~mm}, \mathbf{2 0}$-pin QFN Package - Top View (Through Package)


## Pin Descriptions

Table 1. Pin Descriptions

| Number | Name | Description |
| :---: | :---: | :--- |
| 1 | D5 | 16dB attenuation control bit. This pin is activated by logic HIGH (see Table 11). [a] |
| 2 | RF1 | Device RF input or output (bi-directional). |
| 3 | DATA | Serial interface data input. |
| 4 | CLK | Serial interface clock input. |
| 5 | LE | Serial interface latch enable input. Internal pull-up (100kS). See "Programming" section for proper <br> usage of this line. |
| 6 | VDD | Power supply pin. |
| $7-9,12,18$ | NC | No internal connection. These pins can be left unconnected, have a voltage applied, or be connected to <br> ground (recommended) |
| 10,11 | GND | Internally grounded. Connect pin directly to paddle ground or as close as possible to the pin with thru <br> vias. |
| 13 | VmoDE | Pull this pin HIGH for Serial Control Mode. Ground this pin for Parallel Control Mode. |
| 14 | RF2 | Device RF input or output (bi-directional). |
| 15 | D4 | 8dB attenuation control bit. This pin is activated by logic HIGH (see Table 11). |
| 16 | D3 | 4dB attenuation control bit. This pin is activated by logic HIGH (see Table 11). |

[a] There is a $100 \mathrm{k} \Omega$ pull-up resistor to the internally regulated 2.5 V power supply.

## Renesns

## Absolute Maximum Ratings

The absolute maximum ratings are stress ratings only. Stresses greater than those listed below can cause permanent damage to the device. Functional operation of the F 1975 at absolute maximum ratings is not implied. Exposure to absolute maximum rating conditions could affect device reliability.

Table 2. Absolute Maximum Ratings

| Parameter | Symbol | Minimum | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: |
| $V_{\text {DD }}$ to GND | $V_{D D}$ | -0.3 | +5.5 | V |
| DATA, LE, CLK, D[5:0], V Mode | $V_{\text {Logic }}$ | -0.3 | $\begin{gathered} \text { Minimum } \\ \left(V_{D D}+0.3,3.6\right) \end{gathered}$ | V |
| RF1, RF2 | $V_{\text {RF }}$ | -0.3 | +0.3 | V |
| Maximum Input Power Applied to RF1 or RF2 (>100MHz) | $\mathrm{P}_{\text {RF }}$ |  | +34 | dBm |
| Continuous Power Dissipation | $\mathrm{P}_{\text {diss }}$ |  | 1.75 | dBm |
| Junction Temperature | TJ |  | +140 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature Range | TSTOR | -65 | +150 | ${ }^{\circ} \mathrm{C}$ |
| Lead Temperature (soldering, 10s) |  |  | +260 | ${ }^{\circ} \mathrm{C}$ |
| Electrostatic Discharge - HBM (JEDEC/ESDA JS-001-2012) | Vesohbm |  | $\begin{gathered} 2000 \\ \text { (Class 2) } \end{gathered}$ | V |
| Electrostatic Discharge - CDM (JEDEC 22-C101F) | $V_{\text {Esdcom }}$ |  | $\begin{gathered} 250 \\ \text { (Class C1) } \end{gathered}$ | V |

## Recommended Operating Conditions

Table 3. Recommended Operating Conditions

| Parameter | Symbol | Condition | Minimum | Typical | Maximum | Units |
| :--- | :---: | :--- | :---: | :---: | :---: | :---: |
| Supply Voltage(s) | $\mathrm{V}_{\mathrm{DD}}$ |  | 3.00 |  | 5.25 | V |
| Frequency Range | $\mathrm{f}_{\mathrm{RF}}$ |  | 5 |  | 3000 | MHz |
| Operating Temperature Range | $\mathrm{T}_{\mathrm{EP}}$ | Exposed paddle | -40 |  | 105 | ${ }^{\circ} \mathrm{C}$ |
| RF CW Input Power | $\mathrm{P}_{\mathrm{CW}}$ | RF1 or RF2 |  |  | See Figure 3 | dBm |
| RF1 Impedance | $\mathrm{Z}_{\mathrm{RF} 1}$ | Single-ended |  | 75 |  | $\Omega$ |
| RF2 Impedance | $\mathrm{Z}_{\mathrm{RF} 2}$ | Single-ended |  | 75 |  | $\Omega$ |

Figure 3. Maximum Continuous Operating RF Input Power versus Input Frequency (+25 ${ }^{\circ} \mathbf{C}$ )


## Renesas

## Electrical Characteristics

The specifications in Table 4 apply at $\mathrm{V}_{\mathrm{DD}}=+3.3 \mathrm{~V}, \mathrm{~T}_{E P}=+25^{\circ} \mathrm{C}, \mathrm{f}_{\mathrm{RF}}=1000 \mathrm{MHz}, \mathrm{P}_{\mathrm{IN}}=0 \mathrm{dBm}$, Serial Mode, $\mathrm{Z}_{\mathrm{S}}=\mathrm{Z}_{\mathrm{L}}=75 \Omega$, Evaluation Board (EVKit) trace and connector losses are de-embedded, unless otherwise noted.

Table 4. Electrical Characteristics

| Parameter | Symbol | Condition | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Logic Input High Threshold | $\mathrm{V}_{\mathrm{H}}$ | All control pins |  |  |  |  |
|  |  | $V_{D D}>3.6 \mathrm{~V}$ | $1.17{ }^{\text {a] }}$ |  | 3.6 | V |
|  |  | $3.0 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD}} \leq 3.6 \mathrm{~V}$ | 1.17 |  | $V_{D D}$ |  |
| Logic Input Low Threshold | VIL | All control pins |  |  | 0.63 | V |
| Logic Current | $\mathrm{IHH}_{\text {, }} \mathrm{IL}$ | All control pins | -35 |  | +35 | $\mu \mathrm{A}$ |
| Supply Current ${ }^{[b]}$ | ldo | $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ |  | 550 | 830 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DD}}=5.0 \mathrm{~V}$ |  | 620 | 900 |  |
| RF1 Return Loss | $S_{11}$ |  |  | 18 |  | dB |
| RF2 Return Loss | $\mathrm{S}_{22}$ |  |  | 18 |  | dB |
| Attenuation Step | LSB | Least significant bit |  | 0.5 |  | dB |
| Insertion Loss (Minimum Attenuation) | Amin $^{\text {a }}$ | $\mathrm{D}[5: 0]=[000000 \mathrm{Bm}]$ (IL State) |  | 1.2 | 2.0 | dB |
| Attenuation Range | Arange | $D[5: 0]=\left[111111_{\mathrm{BIN}}\right]=31.5 \mathrm{~dB}$ | 30.5 | 31.1 | 31.7 | dB |
| Step Error | DNL |  |  | 0.1 |  | dB |
| Absolute Error | INL | $D[5: 0]=\left[100111_{\text {Bin }}\right]=19.5 \mathrm{~dB}$ | -0.7 |  | +0.5 | dB |
| Insertion Phase Delta | $\Phi_{\Delta}$ | $\mathrm{f}_{\text {RF }}=0.5 \mathrm{GHz}$ ( $\mathrm{A}_{\text {max }}$ to $\mathrm{A}_{\text {min }}$ ) |  | 10 |  | deg |
|  |  | $\mathrm{f}_{\text {RF }}=1.0 \mathrm{GHz}$ ( $\mathrm{Amax}^{\text {to }}$ Amin) |  | 20 |  |  |
| Input IP3 | IIP3 | $\begin{aligned} & \mathrm{P}_{\mathrm{IN}}=+10 \mathrm{dBm} / \text { tone }, \\ & \mathrm{f}_{1}=900 \mathrm{MHz}, \mathrm{f}_{2}=950 \mathrm{MHz} \end{aligned}$ |  |  |  |  |
|  |  | Attn $=0.0 \mathrm{~dB}, \mathrm{RF}_{\text {IN }}=$ RF1 | 60 | 64 |  | dBm |
|  |  | Attn $=15.5 \mathrm{~dB}, \mathrm{RF}_{10}=\mathrm{RF} 1$ | 59 | 62 |  |  |

[a] Specifications in the minimum/maximum columns that are shown in bold italics are guaranteed by test. Specifications in these columns that are not shown in bold italics are guaranteed by design characterization.
[b] Current is tested using the Serial Mode with parallel pins floating. If parallel pins are grounded, add $25 \mu \mathrm{~A}$ per pin.

## Electrical Characteristics (continued)

The specifications in Table 5 apply at $\mathrm{V}_{\mathrm{DD}}=+3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{EP}}=+25^{\circ} \mathrm{C}$, $\mathrm{f}_{\mathrm{RF}}=1000 \mathrm{MHz}, \mathrm{P}_{\mathrm{IN}}=0 \mathrm{dBm}$, Serial Mode, $\mathrm{Z}_{\mathrm{S}}=\mathrm{Z}_{\mathrm{L}}=75 \Omega$, Evaluation Board (EVKit) trace and connector losses are de-embedded, unless otherwise noted.

Table 5. Electrical Characteristics

| Parameter | Symbol | Condition | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Input IP2 | IIP2 | $\begin{aligned} & \mathrm{P}_{\text {IN }}=+12 \mathrm{dBm} / \text { tone } \\ & \mathrm{f}_{1}=945 \mathrm{MHz}, \\ & \mathrm{f}_{2}=949 \mathrm{MHz} \\ & \mathrm{f}_{1}+\mathrm{f}_{2}=1894 \mathrm{MHz} \\ & \mathrm{RF} \text { IN }=\mathrm{RF} 1 \end{aligned}$ |  | 125 |  | dBm |
| Second Harmonic | H2 | $\begin{aligned} & \mathrm{P}_{\mathrm{IN}}=+15 \mathrm{dBm} \\ & \mathrm{RF}_{\text {IN }}=945 \mathrm{MHz} \\ & \mathrm{RF}_{\text {out }}=1890 \mathrm{MHz} \\ & \mathrm{RF}_{\mathrm{IN}_{\mathrm{N}}}=\mathrm{RF} 1 \end{aligned}$ |  | 108 |  | dBc |
| Input 0.1dB Compression [c] | $\mathrm{PP}_{0.1}$ | $\begin{aligned} & \mathrm{D}[5: 0]=[000000]=\mathrm{A}_{\text {MiN }}, \\ & \mathrm{RF}_{\mathrm{F}_{\mathrm{N}}}=\mathrm{RF} 1 \end{aligned}$ |  | 30.5 |  | dBm |
| MSB Step Time | tıSB | Start at LE rising edge End $\pm 0.10 \mathrm{~dB}$ Pout settling for 15.5 dB to 16.0dB transition |  | 500 |  | ns |
| Maximum Spurious Level on any RF Port [d] | SPURmax |  |  | -130 |  | dBm |
| Maximum Switching Rate | SW ${ }_{\text {Rate }}$ |  |  | 25 |  | kHz |
| DSA Settling Time ${ }^{\text {[e] }}$ | $\tau_{\text {set }}$ | Maximum to minimum attenuation to settle to within 0.5 dB of final value |  | 0.9 |  | $\mu \mathrm{s}$ |
|  |  | Maximum to minimum attenuation to settle to within 0.5 dB of final value |  | 1.8 |  |  |
| Control Interface | SPIBIT |  |  | 6 |  | bit |
| Serial Clock Speed | SPIclı |  |  |  | 25 | MHz |

[c] The input 0.1 dB compression point is a linearity figure of merit. Refer to "Absolute Maximum Ratings" section for the maximum RF input power. This specification is measured in a $50 \Omega$ system.
[d] Spurious due to on-chip negative voltage generator. Typical generator fundamental frequency is 2.2 MHz .
[e] Speeds are measured after SPI programming is completed (data latched with LE $=$ HIGH).

## Thermal Characteristics

Table 6. Package Thermal Characteristics

| Parameter | Symbol | Value | Units |
| :--- | :---: | :---: | :---: |
| Junction to Ambient Thermal Resistance | $\theta_{\mathrm{JA}}$ | 50 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Junction to Case Thermal Resistance <br> (Case is defined as the exposed paddle) | $\theta_{\mathrm{JC} \text {-BOT }}$ | 3 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Moisture Sensitivity Rating (Per J-STD-020) |  | MSL 1 |  |

## Typical Operating Conditions (TOC)

Unless otherwise noted for the TOC graphs on the following pages, the following conditions apply.

- $V_{D D}=+3.3 \mathrm{~V}$
- $Z_{L}=Z_{S}=75 \Omega$ single-ended
- $\mathrm{T}_{\mathrm{EP}}=+25^{\circ} \mathrm{C}$
- $f_{R F}=1 \mathrm{GHz}$
- $P_{\text {IN }}=0 \mathrm{dBm}$ for single tone measurements
- $P_{I N}=+10 \mathrm{dBm} /$ tone for multi-tone measurements
- Tone spacing $=50 \mathrm{MHz}$
- Evaluation Board connector and board losses are de-embedded
- Measured in a $75 \Omega$ system unless otherwise specified


## Typical Performance Characteristics

Figure 4. Insertion Loss vs. Frequency


Figure 6. RF1 Return Loss vs. Frequency (All States)


Figure 8. RF2 Return Loss vs. Frequency (All States)


Figure 5. Insertion Loss vs. Attenuation State


Figure 7. RF1 Return Loss vs. Attenuation State


Figure 9. RF2 Return Loss vs. Attenuation State


## Typical Performance Characteristics

Figure 10. Relative Insertion Phase vs. Frequency (All States)


Figure 12. Worst-Case Absolute Accuracy Error


Figure 14. Worst-Case Step Accuracy


Figure 11. Relative Insertion Phase vs. Attenuation


Figure 13. Accuracy Error vs. Attenuation


Figure 15. Step Error vs. Attenuation


## Typical Performance Characteristics

Figure 16. Compression versus Input Power [Attenuation $\mathbf{= 0 . 0 d B ]}$


Figure 17. Input IP3 versus Attenuation Setting


## Renesas

## Programming

The F1975 can be programmed using either the parallel or the serial interface, which is selectable via $\mathrm{V}_{\text {MODE }}$ (pin 13). Serial Mode is selected by floating $\mathrm{V}_{\text {MODE }}$ or pulling it to a logic HIGH, and Parallel Mode is selected by setting $\mathrm{V}_{\text {MODE }}$ to a logic LOW.

For a comparison of the F1975 and F1975 products, see the Application Note AN945 - Comparison of F1975 and F1975 Digital Step Attenuator Serial Programming Methods.

## Serial Control Mode

The F1975 Serial Mode is selected by floating $\mathrm{V}_{\text {MODE }}$ (pin 13) or pulling it to a logic HIGH. The serial interface is a 6 -bit shift register and shifts in the most significant bit (MSB) (D5 bit) first.

Table 7. 6 Bit SPI DATA Word Sequence

| Bit | Definition |
| :--- | :--- |
| D5 | Attenuation 16dB Control Bit |
| D4 | Attenuator 8dB Control Bit |
| D3 | Attenuator 4dB Control Bit |
| D2 | Attenuator 2dB Control Bit |
| D1 | Attenuator 1dB Control Bit |
| D0 | Attenuator 0.5dB Control Bit |

Table 8. Truth Table for Serial Control Word Bits

| D5 <br> (MSB) | D4 | D3 | D2 | D1 | D0 <br> (LSB) | Attenuation (dB) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0 | 0 | 0 | 0 | 0 | 1 | 0.5 |
| 0 | 0 | 0 | 0 | 1 | 0 | 1 |
| 0 | 0 | 0 | 1 | 0 | 0 | 2 |
| 0 | 0 | 1 | 0 | 0 | 0 | 4 |
| 0 | 1 | 0 | 0 | 0 | 0 | 8 |
| 1 | 0 | 0 | 0 | 0 | 0 | 16 |
| 1 | 1 | 1 | 1 | 1 | 1 | 31.5 |

## Renesns

## Serial Mode Programming

In the Serial Mode, the F1975 is programmed via the serial port on the rising edge of the Latch Enable (LE) signal. It is required that LE be kept at logic LOW until all data bits are clocked into the shift register. The F1975 will change its attenuation state after the data word is latched into the active register as illustrated in Figure 18. After the data word in the shift register has been latched into the active register, the LE signal must be dropped LOW. This allows shifting new data into the shift register without uploading it to the active register until the next time LE goes HIGH. The timing specification intervals are shown in blue font in Figure 18.

Figure 18. Serial Register Timing Diagram


Note: If the Serial Register programming method is used, the attenuator will change to the new attenuation state only after the data word is latched into the active register, a single programming event.

## Table 9. Serial Mode Timing Table

| Interval Symbol | Description | Min Spec | Max Spec | Units |
| :---: | :--- | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{mc}}$ | Parallel Mode to Serial Mode setup time: from the rising edge of $\mathrm{V}_{\text {MODE }}$ <br> to the rising edge of CLK for the D5 bit | 100 | ns |  |
| $\mathrm{t}_{\mathrm{ds}}$ | Clock HIGH pulse width | 10 |  | ns |
| $\mathrm{t}_{\mathrm{cls}}$ | LE setup time: from the rising edge of the CLK pulse for DO to LE rising <br> edge minus half the clock period | 10 | ns |  |
| $\mathrm{t}_{\mathrm{clh}}$ | LE hold time: from the falling edge of the LE pulse to the rising edge of <br> CLK | 10 | ns |  |
| $\mathrm{t}_{\text {lew }}$ | LE pulse width | 10 |  | ns |
| $\mathrm{t}_{\mathrm{dcs}}$ | Data setup time: from the starting edge of the data bit to the rising edge <br> of CLK | 10 | ns |  |
| $\mathrm{t}_{\mathrm{dht}}$ | Data hold time: from rising edge of CLK to falling edge of the data bit | 10 |  | ns |

## Serial Mode Default Startup Condition

When the device is first powered up, it will default to the maximum attenuation of 31.5 dB independent of the parallel pin [D5:D0] conditions.

## Table 10. Default Control Word for the Serial Mode

| D5 (MSB) | D4 | D3 | D2 | D1 | D0 (LSB) | Attenuation (dB) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 1 | 1 | 1 | 1 | 1 | 31.5 |

## Parallel Control Mode

For the F1975, the user has the option of programming in one of two parallel modes: Direct Parallel Mode or Latched Parallel Mode.

## Direct Parallel Mode

Direct Parallel Mode is selected when $V_{\text {MODE }}$ (pin 13) is set to a logic LOW and LE (pin 5 ) is set to a logic HIGH. In this mode, the device will immediately react to any voltage changes in the parallel control pins (1, 15, 16, 17, 19, and 20). Use direct parallel mode for the fastest settling time.

## Direct Parallel Default Startup Condition

In the Direct Parallel Mode, the attenuation value is determined by the logic condition of the parallel pins $(1,15,16,17,19$, and 20$)$ at the time of start-up.

## Latched Parallel Mode

The Latched Parallel Mode is selected when $\mathrm{V}_{\text {mOde }}$ is set to a logic LOW and LE (pin 5) is toggled from a logic LOW to a logic HIGH.
To utilize the Latched Parallel Mode, complete these steps:

- Set the LE pin to a logic LOW.
- Set pins $1,15,16,17,19$, and 20 for the desired attenuation setting. (While LE is set to a logic LOW, the attenuation state will not change.)
- Toggle LE to a logic HIGH. The device will then transition to the attenuation settings reflected by pins D5 through D0.


## Latched Parallel Default Startup Condition

The Latched Parallel Mode establishes a default attenuation state when the device is first powered up which is the maximum attenuation.
Table 11. Truth Table for the Parallel Pins

| D5 | D4 | D3 | D2 | D1 | D0 | Attenuation (dB) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0 | 0 | 0 | 0 | 0 | 1 | 0.5 |
| 0 | 0 | 0 | 0 | 1 | 0 | 1 |
| 0 | 0 | 0 | 1 | 0 | 0 | 2 |
| 0 | 0 | 1 | 0 | 0 | 0 | 4 |
| 0 | 1 | 0 | 0 | 0 | 0 | 8 |
| 1 | 0 | 0 | 0 | 0 | 0 | 16 |
| 1 | 1 | 1 | 1 | 1 | 1 | 31.5 |

Figure 19. Latched Parallel Mode Timing Diagram


Table 12. Latched Parallel Mode Timing

| Interval Symbol | Description | Min Spec | Max Spec | Units |
| :---: | :--- | :---: | :---: | :---: |
| tsps $^{\text {SPDH }}$ | Serial Mode to Parallel Mode setup time | 100 |  | ns |
| tPDH | Parallel data hold time | 10 |  | ns |
| tPDS | LE minimum pulse width | 10 |  | ns |
| $\mathrm{t}_{\text {LE }}$ | Parallel data setup time | 10 |  | ns |

## Applications Information

## F1975 Digital Pin Voltage and Resistance Values (Pins not Connected)

Table 13 lists the resistance between various pins and ground when no DC power is applied. When the device is powered up with $+5 \mathrm{~V} D \mathrm{DC}$, these pins will exhibit a voltage to ground as indicated.

Table 13. Voltage and Resistance to Ground for the Logic Pins

| Pin | Name | DC Voltage (Volts) | Resistance (Ohms) |
| :---: | :---: | :---: | :---: |
| 13 | $\mathrm{~V}_{\text {MODE }}$ | 2.5 V | $100 \mathrm{k} \Omega$ pull-up resistor to internally regulated 2.5 V. |
| $3,4,5$ | DATA, CLK, LE | 2.5 V | $100 \mathrm{k} \Omega$ pull-up resistor to internally regulated 2.5 V. |
| $1,15-17$, <br> 19,20 | D5, D4, D3, <br> D2, D1, DO | 2.5 V | $100 \mathrm{k} \Omega$ pull-up resistor to internally regulated 2.5 V. |

## F1975 Evaluation Kit

Figure 20. F1975EVBI Evaluation Board - Top View


Figure 21. F1975EVBI Evaluation Board - Back View


## Evaluation Kit / Applications Circuit

Figure 22. Electrical Schematic


## Bill of Materials (BOM)

Table 14. Evaluation Kit Bill of Material

| Part Reference | QTY | Description | Manufacturer Part \# | Manufacturer |
| :---: | :---: | :---: | :---: | :---: |
| C1, C11, C15 | 3 | $100 \mathrm{nF} \pm 10 \%$, 16V, X7R Ceramic Capacitor (0402) | GRM155R71C104K | MURATA |
| C2, C10 | 2 | $10 \mathrm{nF} \pm 5 \%, 50 \mathrm{~V}$, X7R Ceramic Capacitor (0603) | GRM188R71H103J | MURATA |
| $\begin{gathered} \text { C3-C9, } \\ \text { C12, C13, C14 } \end{gathered}$ | 10 | 100pF $\pm 5 \%, 50 \mathrm{~V}, \mathrm{COG}$ Ceramic Capacitor (0402) | GRM1555C1H101J | MURATA |
| R3-R9 | 7 | $100 \Omega \pm 1 \%, 1 / 10 \mathrm{~W}$, Resistor (0402) | ERJ-2RKF1000X | PANASONIC |
| R10-R13, R15-R18, R24-R27 | 12 | $0 \Omega$ Resistor (0402) | ERJ-2GE0R00X | PANASONIC |
| R21, R22, R23 | 3 | $3 \mathrm{k} \Omega \pm 1 \%, 1 / 10 \mathrm{~W}$, Resistor (0402) | ERJ-2RKF3001X | PANASONIC |
| R1 | 1 | $8.25 \mathrm{k} \Omega \pm 1 \%, 1 / 10 \mathrm{~W}$, Resistor (0402) | ERJ-2RKF8251X | PANASONIC |
| R2 | 1 | 10kS $\pm 5 \%$, 1/10W, Resistor (0402) | ERJ-2RKF1002X | PANASONIC |
| J2, J3, J5 | 3 | Conn Header Vert SGL 2 X 1 Pos Gold | 961102-6404-AR | 3M |
| J11 | 1 | Conn Header Vert DBL 4 X 2 Pos Gold | 67997-108HLF | FCI |
| J4 | 1 | Conn Header Vert SGL 9 X 1 Pos Gold | 961109-6404-AR | 3M |
| J1, J8 | 2 | Edge Launch SMA <br> ( 0.250 inch pitch ground, round) | 142-0711-821 | Emerson Johnson |
| J6, J7, J12, J13 | 4 | Edge Launch F-type 75 Ohm | 222181 | Amphenol |
| U2 | 1 | Switch 8-Position Dip Switch | KAT1108E | E-Switch |
| U1 | 1 | DSA | F1975NCGI | IDT |
|  | 1 | Printed Circuit Board | F1975 EVKit Rev 02 | IDT |

## Evaluation Kit Operation

## Power Supply Setup

Set up a power supply in the voltage range of 3.0 V to 5.25 V with the power supply output disabled. The voltage can be applied via one of the following connections (see Figure 23):

- J8 connector
- J 5 header connection (note the polarity of the GND pin on this connector)
- Pin $8\left(\mathrm{~V}_{\mathrm{DD}}\right)$ and pin $9(\mathrm{GND})$ on the J 4 header connection

Figure 23. Power Supply and Logic Voltage Connections


## Parallel Logic Control Setup

The Evaluation Board has the ability to control the F1975 in the Parallel Mode. For external control, apply logic voltages to the J 4 header pins 1 through 6 (see Figure 20). For manual control, switches 1 through 6 on U2 can be set. The switch is a three-position switch. The bottom position " - " will ground the pin. The center position " 0 " will leave the pin open circuited. Setting the switch to the top position " + " will apply a voltage that is supplied to the switch.
The logic voltage can be applied in one of two ways (see Figure 23):

- Direct connection to connector J1.
- Leave J 1 open circuit, and add jumpers to headers J 2 and J 3 . This will apply a logic voltage that is $0.24 * V_{\mathrm{DD}}$.

The F1975 has internal pull-up resistors for the D0 - D5 parallel pins and $\mathrm{V}_{\text {modes }}$. The switches can be used to apply a logic LOW (ground) for proper operation. To use the Parallel Mode, either apply a ground to the VMOD pin 7 on J4 or set U2 switch 7 (VMOD) to the "-" position (see Figure 20). The attenuation setting can be set via the U2 switches 1 through 6 (D0 through D5) according to Table 11.

## Serial Logic Control Setup

The Evaluation Board has the ability to control the F1975 in the Serial Mode. Connect the serial controller to the J11 header connection as shown in Figure 24. To use the Serial Mode, set U2 switch 7 to the " + " or "O" position.
The attenuation setting can be programmed according to Table 8.
Figure 24. Serial Logic Connections


## Power-On Procedure

Set up the voltage supplies and Evaluation Board as described in the "Power Supply Setup" section and either the "Parallel Logic Control Setup" or "Serial Logic Control Setup" sections above.
Enable the $V_{D D}$ supply.
Enable the proper attenuation setting according to Figure 20 and Table 8 for Serial Mode or Table 11 for the Parallel Mode.

## Power-Off Procedure

Set the logic control pins to a logic LOW.
Disable the $V_{D D}$ supply.

## Package Drawings

The package outline drawings are located at the end of this document. The package information is the most current data available and is subject to change without notice or revision of this document.

## Marking Diagram



1. Line 1 and 2 are the part number.
2. Line 3: "ZA" is for die version.
3. Line 3: "yww" = " 515 " = one digit year and two digit week that the part was assembled.
4. Line 3: "BEG" denotes assembly site.

## Ordering Information

| Orderable Part Number | Description and Package | MSL Rating | Shipping Packaging | Temperature |
| :--- | :--- | :---: | :---: | :---: |
| F1975NCGI | $4 \mathrm{~mm} \times 4 \mathrm{~mm} \times 0.75 \mathrm{~mm}$ QFN | 1 | Tray | $-40^{\circ} \mathrm{C}$ to $+105^{\circ} \mathrm{C}$ |
| F1975NCGI8 | $4 \mathrm{~mm} \times 4 \mathrm{~mm} \times 0.75 \mathrm{~mm}$ QFN | 1 | Reel | $-40^{\circ} \mathrm{C}$ to $+105^{\circ} \mathrm{C}$ |
| F1975EVBI | Evaluation Board |  |  |  |
| F1975EVSI | Evaluation Solution including the Evaluation Board, Controller Board, and cable. The Evaluation Software is <br> available for download on the product page on the IDT website: $w w w . I D T . c o m / F 1975 ~$ |  |  |  |

## Revision History

| Revision | Revision Date | Description of Change |
| :---: | :---: | :--- |
| 1 | September 21, 2017 | Updated evaluation board images, top markings, and updated to the latest template. |
| 0 | July 31, 2017 | Initial release of the datasheet. |




RECOMMENDED LAND PATTERN DIMENSION

NOTE:

1. ALL DIMENSION ARE IN MM. ANGLES IN DEGREES
2. TOP DOWN VIEW AS VIEWED ON PCB
3. LAND PATTERN RECOMMENDATION PER IPC-7351B GENERIC REQUREMENT FOR SURFACE MPOUNT DESIGN AND LAND PATTERN

| Package Revision History |  |  |
| :--- | :--- | :--- |
| Date Created | Rev No. | Description |
| Sept 12,2017 | Rev 01 | Correct Title |
| Sept 11,2017 | Rev 00 | Initial Release |

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